



**THE DATASHEET OF  
CY7C188-20VC**



## Features

- High speed
  - 20 ns
- Automatic power-down when deselected
- Low active power
  - 935 mW
- Low standby power
  - 83 mW
- CMOS for optimum speed/power
- TTL-compatible inputs and outputs
- Easy memory expansion with  $\overline{CE}_1$ ,  $CE_2$ , and  $\overline{OE}$  features
- Available in non Pb-free 32-Lead (300-Mil) Molded SOJ

## Functional Description

The CY7C188 is a high-performance CMOS static RAM organized as 32,768 words by 9 bits. Easy memory expansion is provided by an active-LOW chip enable ( $\overline{CE}_1$ ), an active-HIGH chip enable ( $CE_2$ ), an active-LOW output enable ( $\overline{OE}$ ), and tri-state drivers. The device has an automatic power-down feature that reduces power consumption by more than 75% when deselected.

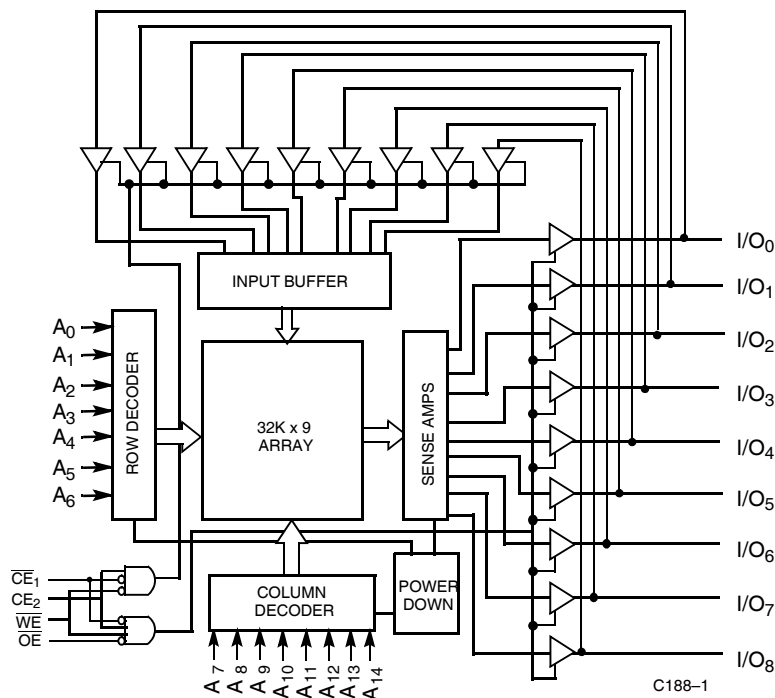
Writing to the device is accomplished by taking  $\overline{CE}_1$  and write enable ( $\overline{WE}$ ) inputs LOW and  $CE_2$  input HIGH. Data on the nine I/O pins ( $I/O_0 - I/O_8$ ) is then written into the location specified on the address pins ( $A_0 - A_{14}$ ).

Reading from the device is accomplished by taking  $\overline{CE}_1$  and  $\overline{OE}$  LOW while forcing  $\overline{WE}$  and  $CE_2$  HIGH. Under these conditions, the contents of the memory location specified by the address pins will appear on the I/O pins.

The nine input/output pins ( $I/O_0 - I/O_8$ ) are placed in a high-impedance state when the device is deselected ( $\overline{CE}_1$  HIGH or  $CE_2$  LOW), the outputs are disabled ( $\overline{OE}$  HIGH), or during a write operation ( $CE_1$  LOW,  $CE_2$  HIGH, and  $\overline{WE}$  LOW).

The CY7C188 is available in standard 300-mil-wide SOJ.

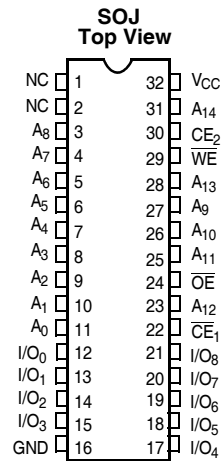
## Logic Block Diagram



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## Pin Configuration



## Selection Guide

Description	-20
Maximum Access Time (ns)	20
Maximum Operating Current (mA)	170
Maximum CMOS Standby Current (mA)	15

### Maximum Ratings

Exceeding the maximum ratings may impair the useful life of the device. These user guidelines are not tested.

- Storage Temperature ..... -65 °C to +150 °C
- Ambient Temperature with Power Applied ..... -55 °C to +125 °C
- Supply Voltage on V<sub>CC</sub> Relative to GND (Pin 32 to Pin 16)..... -0.5 V to +7.0 V
- DC Voltage Applied to Outputs in high Z State<sup>[1]</sup> ..... -0.5 V to V<sub>CC</sub> + 0.5 V

- DC Input Voltage<sup>[1]</sup> ..... -0.5 V to V<sub>CC</sub> + 0.5 V
- Output Current into Outputs (LOW)..... 20 mA
- Static Discharge Voltage..... > 2001 V (per MIL-STD-883, Method 3015)
- Latch-up Current..... > 200 mA

### Operating Range

Range	Ambient Temperature	V <sub>CC</sub>
Commercial	0 °C to +70 °C	5 V ± 10%

### Electrical Characteristics

Over the Operating Range<sup>[2]</sup>

Parameter	Description	Test Conditions	-20		Unit
			Min	Max	
V <sub>OH</sub>	Output HIGH Voltage	V <sub>CC</sub> = Min, I <sub>OH</sub> = -4.0 mA	2.4	-	V
V <sub>OL</sub>	Output LOW Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 8.0 mA	-	0.4	V
V <sub>IH</sub>	Input HIGH Voltage		2.2	V <sub>CC</sub> + 0.3	V
V <sub>IL</sub>	Input LOW Voltage <sup>[1]</sup>		-0.5	0.8	V
I <sub>IX</sub>	Input Leakage Current	GND ≤ V <sub>I</sub> ≤ V <sub>CC</sub>	-5	+5	μA
I <sub>OZ</sub>	Output Leakage Current	GND ≤ V <sub>I</sub> ≤ V <sub>CC</sub> , Output Disabled	-5	+5	μA
I <sub>CC</sub>	V <sub>CC</sub> Operating Supply Current	V <sub>CC</sub> = Max, I <sub>OUT</sub> = 0 mA, f = f <sub>MAX</sub> = 1/t <sub>RC</sub>	-	170	mA
I <sub>SB1</sub>	Automatic CE Power-Down Current — TTL Inputs	Max V <sub>CC</sub> , $\overline{CE}_1 \geq V_{IH}$ or $CE_2 \leq V_{IL}$ , V <sub>IN</sub> ≥ V <sub>IH</sub> or V <sub>IN</sub> ≤ V <sub>IL</sub> , f = f <sub>MAX</sub>	-	35	mA
I <sub>SB2</sub>	Automatic CE Power-Down Current — CMOS Inputs	Max V <sub>CC</sub> , $\overline{CE}_1 \geq V_{CC} - 0.3$ V or $CE_2 \leq 0.3$ V, V <sub>IN</sub> ≥ V <sub>CC</sub> - 0.3 V or V <sub>IN</sub> ≤ 0.3 V, f = 0	-	15	mA

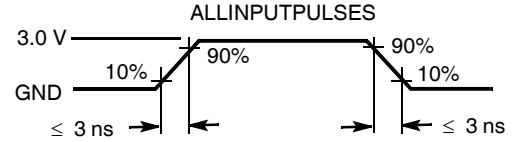
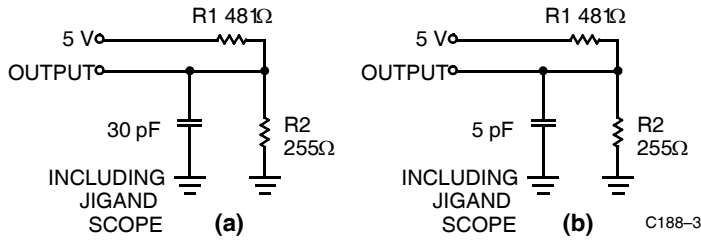
### Capacitance<sup>[3]</sup>

Parameter	Description	Test Conditions	Max	Unit
C <sub>IN</sub> : Addresses	Input Capacitance	T <sub>A</sub> = 25 °C, f = 1 MHz, V <sub>CC</sub> = 5.0 V	6	pF
C <sub>IN</sub> : Controls	Input Capacitance		8	pF
C <sub>OUT</sub>	Output Capacitance		8	pF

**Notes**

1. Minimum voltage is equal to -2.0 V for pulse durations less than 20 ns.
2. See the last page of this specification for Group A subgroup testing information.
3. Tested initially and after any design or process changes that may affect these parameters.

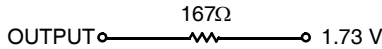
### AC Test Loads and Waveforms<sup>[4, 5]</sup>



C188-3

C188-4

Equivalent to: THÉVENIN EQUIVALENT



### Switching Characteristics

Over the Operating Range<sup>[4, 6]</sup>

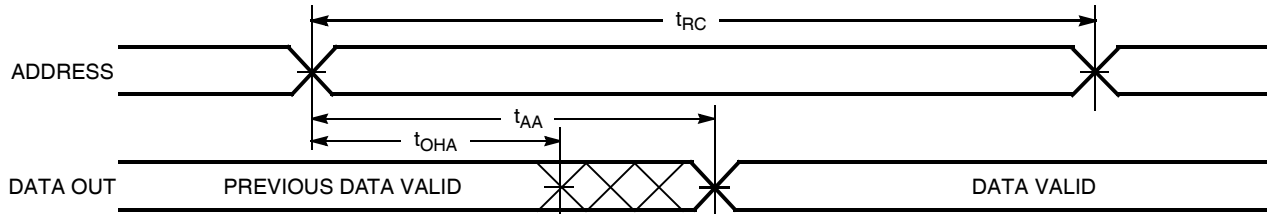
Parameter	Description	-20		Unit
		Min	Max	
<b>READ CYCLE</b>				
$t_{RC}$	Read Cycle Time	20	–	ns
$t_{AA}$	Address to Data Valid	–	20	ns
$t_{OHA}$	Data Hold from Address Change	3	–	ns
$t_{ACE}$	$\overline{CE}_1$ LOW or $CE_2$ HIGH to Data Valid	–	20	ns
$t_{DOE}$	$\overline{OE}$ LOW to Data Valid	–	9	ns
$t_{LZOE}$	$\overline{OE}$ LOW to Low Z <sup>[7]</sup>	0	–	ns
$t_{HZOE}$	$\overline{OE}$ HIGH to High Z <sup>[5, 7]</sup>	–	9	ns
$t_{LZCE}$	$\overline{CE}_1$ LOW or $CE_2$ HIGH to low Z <sup>[7]</sup>	3	–	ns
$t_{HZCE}$	$CE_1$ HIGH or $CE_2$ LOW to high Z <sup>[5, 7]</sup>	–	9	ns
$t_{PU}$	$\overline{CE}_1$ LOW or $CE_2$ HIGH to power-up	0	–	ns
$t_{PD}$	$\overline{CE}_1$ HIGH or $CE_2$ LOW to power-down	–	20	ns
<b>WRITE CYCLE<sup>[8, 9]</sup></b>				
$t_{WC}$	Write Cycle Time	20	–	ns
$t_{SCE}$	$\overline{CE}_1$ LOW or $CE_2$ HIGH to Write End	15	–	ns
$t_{AW}$	Address set-up to Write End	15	–	ns
$t_{HA}$	Address Hold from Write End	0	–	ns
$t_{SA}$	Address set-up to Write Start	0	–	ns
$t_{PWE}$	$\overline{WE}$ Pulse Width	15	–	ns
$t_{SD}$	Data Set-Up to Write End	10	–	ns
$t_{HD}$	Data Hold from Write End	0	–	ns
$t_{HZWE}$	$\overline{WE}$ LOW to high Z <sup>[5]</sup>	0	7	ns
$t_{LZWE}$	$\overline{WE}$ HIGH to low Z <sup>[5, 7]</sup>	3	–	ns

**Notes**

- Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5 V, input pulse levels of 0 to 3.0 V, and output loading of the specified  $I_{OL}/I_{OH}$  and 30-pF load capacitance.
- $t_{HZOE}$ ,  $t_{HZCE}$ , and  $t_{HZWE}$  are specified with  $C_L = 5$  pF as in part (b) of AC Test Loads. Transition is measured  $\pm 500$  mV from steady-state voltage.
- See the last page of this specification for Group A subgroup testing information.
- At any given temperature and voltage condition,  $t_{HZCE}$  is less than  $t_{LZCE}$ ,  $t_{HZOE}$  is less than  $t_{LZOE}$ , and  $t_{HZWE}$  is less than  $t_{LZWE}$  for any given device.
- The internal write time of the memory is defined by the overlap of  $\overline{CE}_1$ , LOW,  $CE_2$  HIGH, and  $\overline{WE}$  LOW. All three signals must be asserted to initiate a write and any signal can terminate a write by being deasserted. The data input set-up and hold timing should be referenced to the rising edge of the signal that terminates the write.
- The minimum write cycle time for write cycle #3 ( $\overline{WE}$  controlled,  $\overline{OE}$  LOW) is the sum of  $t_{HZWE}$  and  $t_{SD}$ .

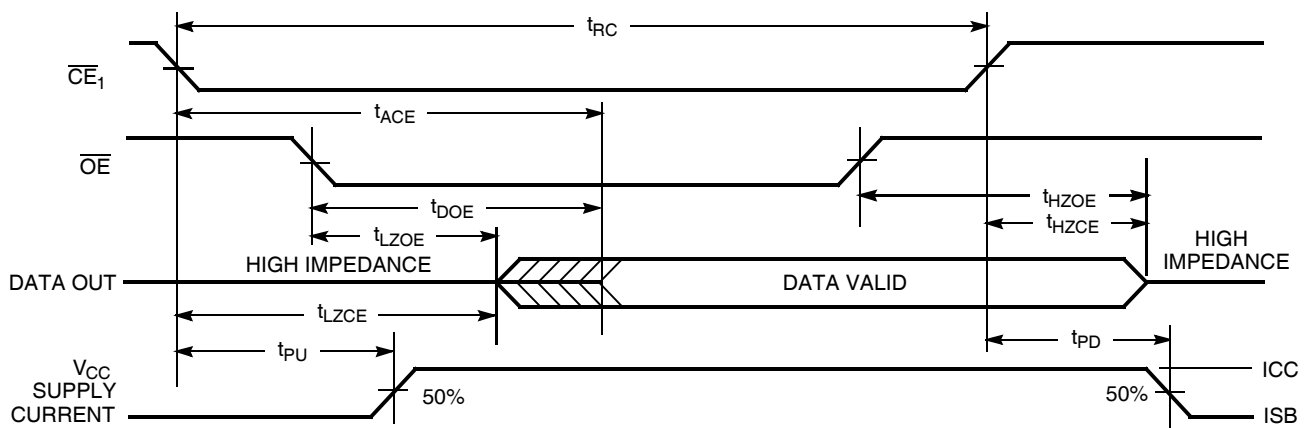
### Switching Waveforms

#### Read Cycle No. 1<sup>[10, 11]</sup>



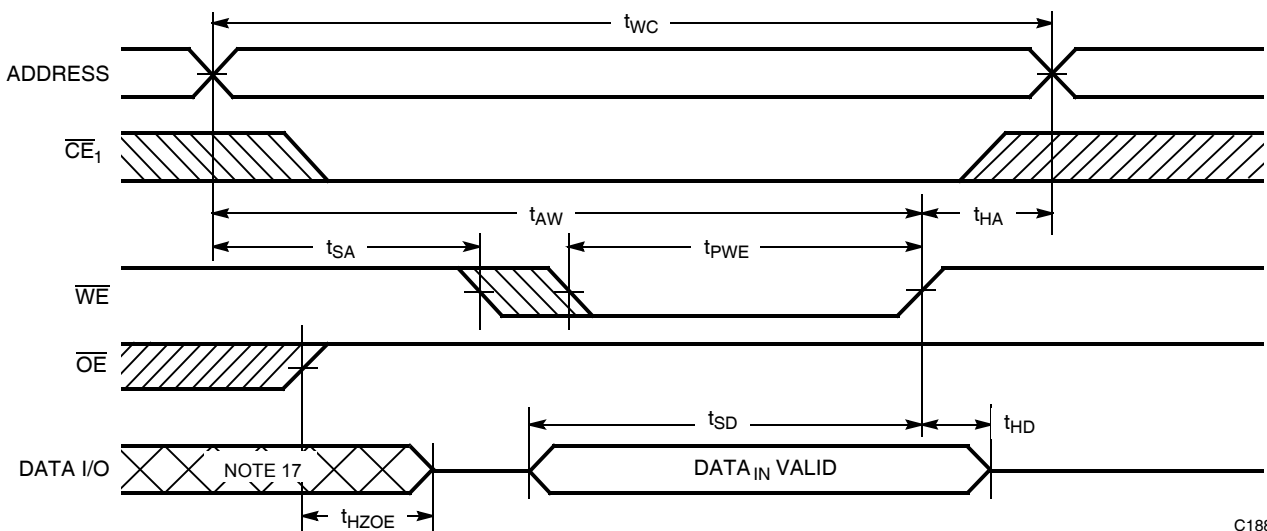
C188-5

#### Read Cycle No. 2 (Chip-Enable Controlled)<sup>[11, 12, 13]</sup>



C188-6

#### Write Cycle No. 1 ( $\overline{WE}$ Controlled)<sup>[13, 14, 15, 16]</sup>



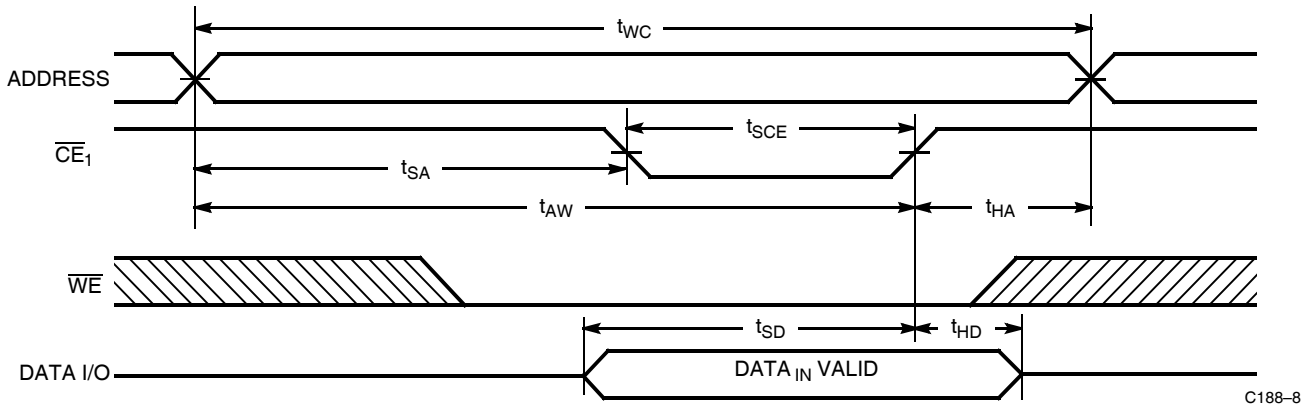
C188-7

**Notes**

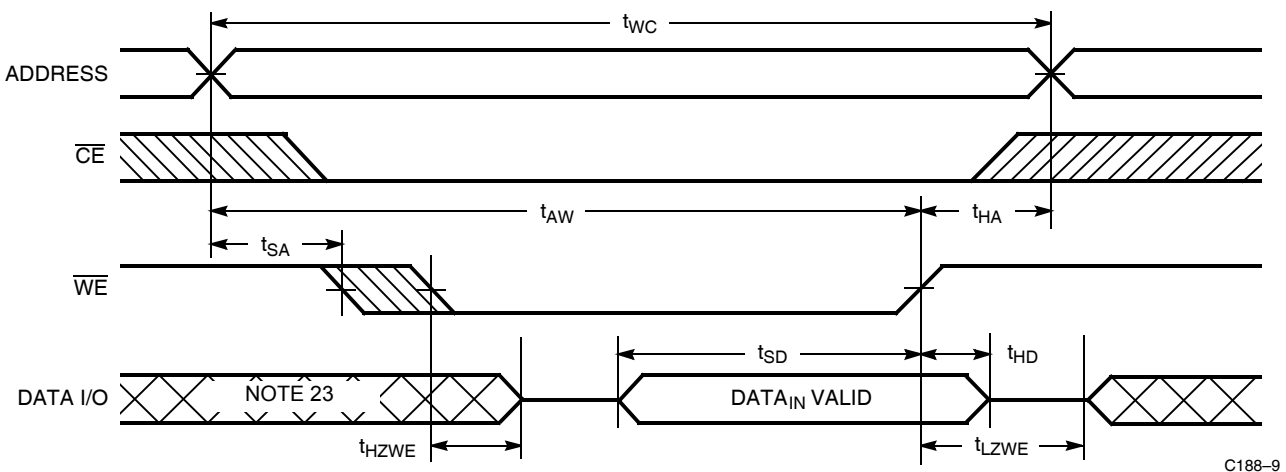
- 10. Device is continuously selected.  $\overline{OE}, \overline{CE} = V_{IL}$ .
- 11. WE is HIGH for read cycle.
- 12. Address valid prior to or coincident with  $\overline{CE}$  transition LOW.
- 13. Timing parameters are the same for all chip enable signals ( $\overline{CE}_1$  and  $\overline{CE}_2$ ), so only the timing for  $\overline{CE}_1$  is shown.
- 14. The internal write time of the memory is defined by the overlap of  $\overline{CE}_1$ , LOW,  $\overline{CE}_2$  HIGH, and WE LOW. All three signals must be asserted to initiate a write and any signal can terminate a write by being deasserted. The data input set-up and hold timing should be referenced to the rising edge of the signal that terminates the write.
- 15. Data I/O is high impedance if  $\overline{OE} = V_{IH}$ .
- 16. If CE goes HIGH simultaneously with WE HIGH, the output remains in a high-impedance state.
- 17. During this period, the I/Os are in the output state and input signals should not be applied.

Switching Waveforms (Continued)

Write Cycle No.2 ( $\overline{CE}$  Controlled)<sup>[18, 20, 21, 22]</sup>



Write Cycle No. 3 ( $\overline{WE}$  Controlled,  $\overline{OE}$  LOW)<sup>[19, 20, 22]</sup>



Truth Table

CE	WE	OE	Input/Output	Mode	Power
H	X	X	High Z	Deselect/Power-Down	Standby ( $I_{SB}$ )
L	H	L	Data Out	Read	Active ( $I_{CC}$ )
L	L	X	Data In	Write	Active ( $I_{CC}$ )
L	H	H	High Z	Deselect, Output Disabled	Active ( $I_{CC}$ )

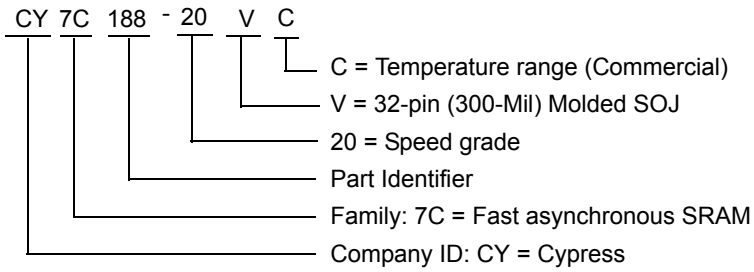
Notes

- 18. The internal write time of the memory is defined by the overlap of  $\overline{CE}_1$ , LOW,  $CE_2$  HIGH, and  $\overline{WE}$  LOW. All three signals must be asserted to initiate a write and any signal can terminate a write by being deasserted. The data input set-up and hold timing should be referenced to the rising edge of the signal that terminates the write.
- 19. The minimum write cycle time for write cycle #3 ( $\overline{WE}$  controlled,  $\overline{OE}$  LOW) is the sum of  $t_{HZWE}$  and  $t_{SD}$ .
- 20. Timing parameters are the same for all chip enable signals ( $CE_1$  and  $CE_2$ ), so only the timing for  $CE_1$  is shown.
- 21. Data I/O is high impedance if  $OE = V_{IH}$ .
- 22. If  $CE$  goes HIGH simultaneously with  $WE$  HIGH, the output remains in a high-impedance state.
- 23. During this period, the I/Os are in the output state and input signals should not be applied.

**Ordering Information**

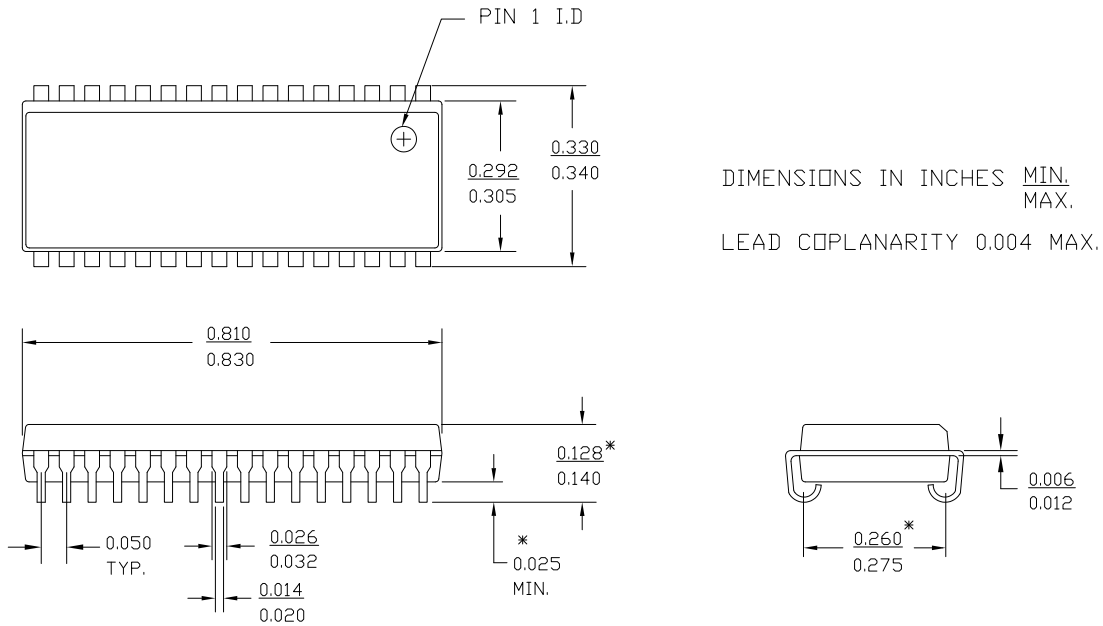
Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
20	CY7C188-20VC	51-85041	32-pin (300-Mil) Molded SOJ	Commercial

**Ordering Code Definitions**



**Package Diagram**

**Figure 1. 32-Lead (300-Mil) Molded SOJ, 51-85041**



51-85041 \*B

### Acronyms

Acronym	Description
CMOS	complementary metal oxide semiconductor
CE	chip enable
DIP	dual inline package
I/O	input/output
OE	output enable
SRAM	static random access memory
SOJ	small outline J-lead
TTL	transistor-transistor logic
WE	write enable

### Document Conventions

#### Units of Measure

Symbol	Unit of Measure
ns	nano seconds
V	Volts
μA	micro Amperes
mA	milli Amperes
mV	milli Volts
mW	milli Watts
pF	pico Farad
°C	degree Celcius
W	Watts
%	percent
MHz	Mega Hertz

## Document History Page

Document Title: CY7C188 32 K × 9 Static RAM Document Number: 38-05053				
REV.	ECN NO.	Issue Date	Orig. of Change	Description of Change
**	107155	09/10/01	SZV	Change from Spec number: 38-00220 to 38-05053
*A	506367	See ECN	NXR	Changed the description of I <sub>IX</sub> from Input Load Current to Input Leakage Current in DC Electrical Characteristics table Removed I <sub>OS</sub> parameter from DC Electrical Characteristics table Updated Ordering Information table
*B	2894123	03/17/2010	VKN	Added Table of Contents Removed 15ns speed bin Updated Ordering Information table Updated Package Diagram (Figure 1) Added Sales, Solutions, and Legal Information
*C	3096933	11/30/2010	PRAS	Added <a href="#">Ordering Code Definitions</a> . Added <a href="#">Acronyms</a> and <a href="#">Units of Measure</a> . Minor edits.

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